

10-bit 20MSPS Video A/D Converter

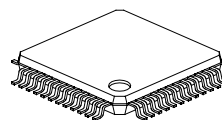
Description

The CXD3300R is a 10-bit CMOS A/D converter for video applications. This IC is ideally suited for the A/D conversion of video signals in TVs, VCRs, camcorders, etc.

Features

- Resolution: 10 bits $\pm 1.0\text{LSB}$ (D.L.E.)
- Maximum sampling frequency: 20MSPS
- Low power consumption: 40mW
(Except self-bias)
- Low input capacitance
- Built-in self-bias circuit

48 pin LQFP (Plastic)



Structure

Silicon gate CMOS IC

Absolute Maximum Ratings (Ta = 25°C)

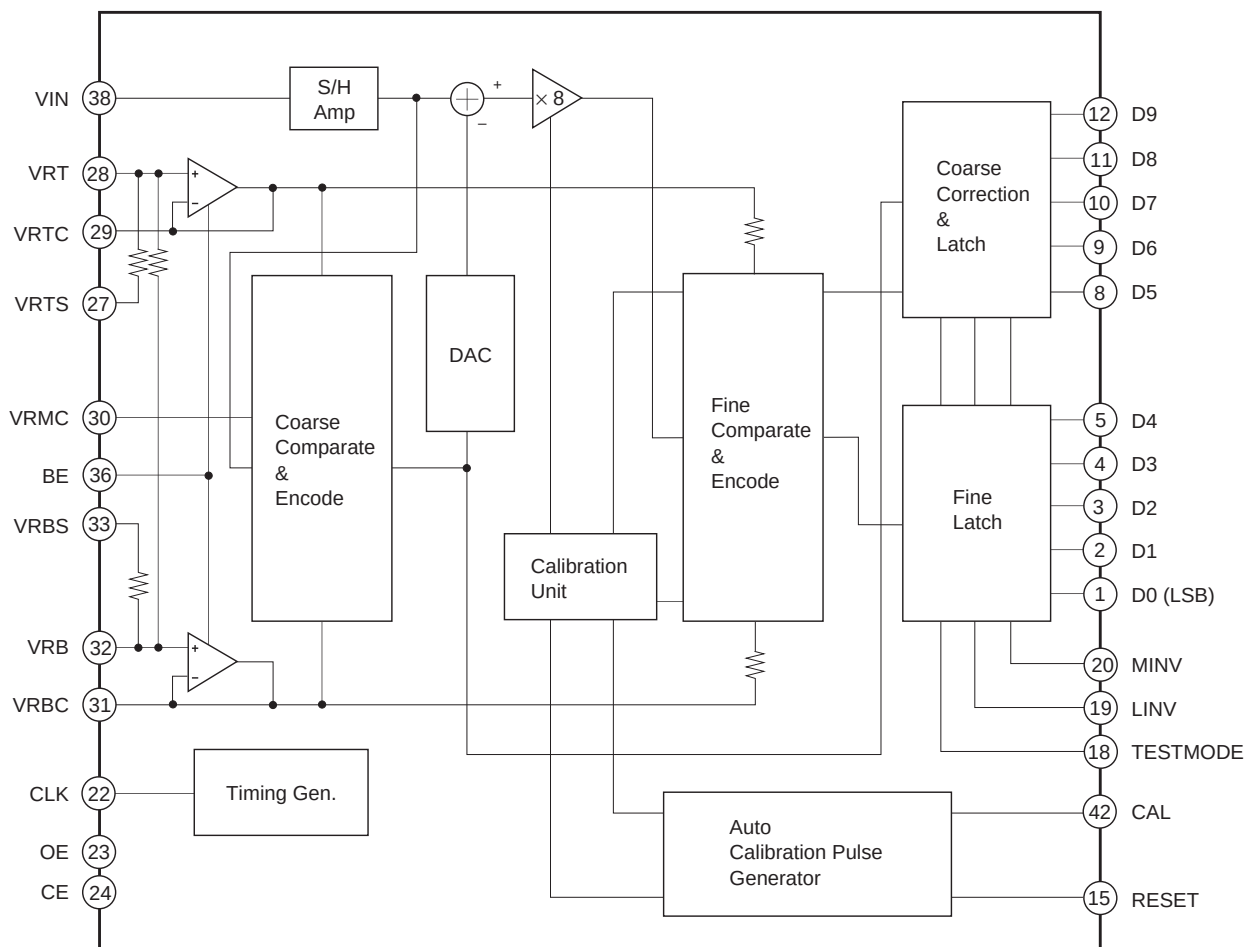
• Supply voltage	AVDD	AVSS – 0.5 to +4.5	V
	DVDD	DVSS – 0.5 to +4.5	V
• Reference voltage	VRT, VRB	AVDD + 0.5 to AVSS – 0.5	V
• Input voltage (analog)	VIN	AVDD + 0.5 to AVSS – 0.5	V
• Input voltage (digital)	VIH, VIL	AVDD + 0.5 to AVSS – 0.5	V
• Output voltage (digital)	VOH, VOL	DVDD + 0.5 to DVSS – 0.5	V
• Storage temperature	Tstg	–55 to +150	°C

Recommended Operating Conditions

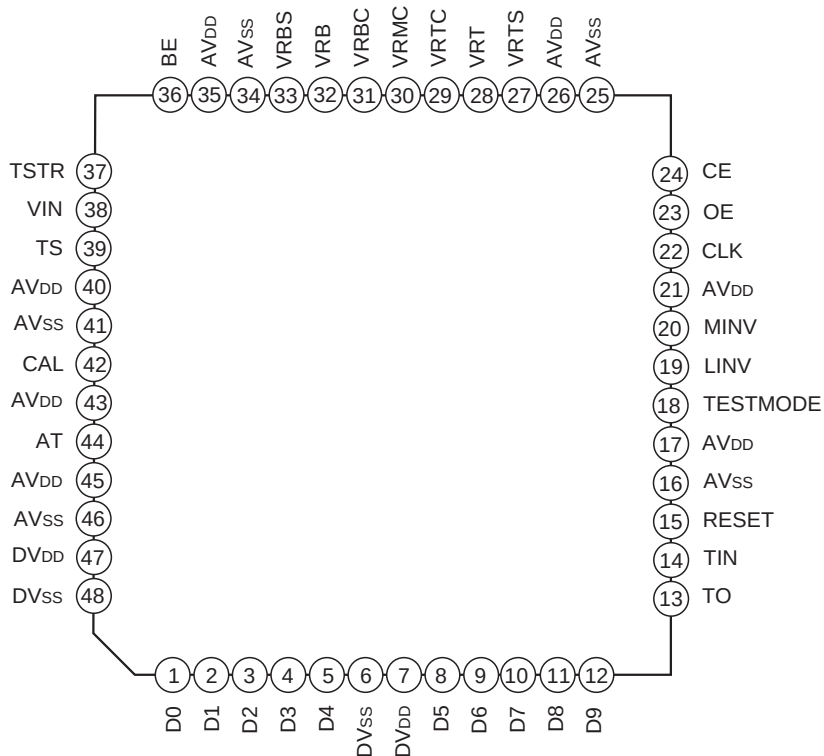
• Supply voltage	AVDD, AVSS	3.0 $\pm$ 0.3	V
	DVDD, DVSS	3.0 $\pm$ 0.3	V
	DVSS – AVSS	0 to 100	mV
• Reference input voltage	VRB	0.3AVDD to 0.5AVDD	V
	VRT	0.6AVDD to 0.8AVDD	V
• Analog input	VIN	0.9Vp-p or more	
• Clock pulse width	tPW1	25 (min.)	ns
	tPW0	25 (min.)	ns
• Operating ambient temperature	Topr	–40 to +85	°C

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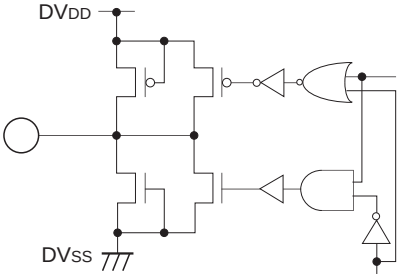
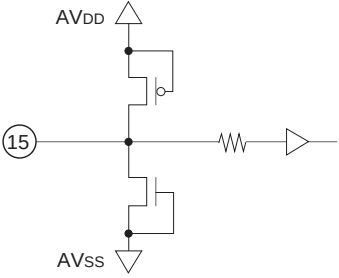
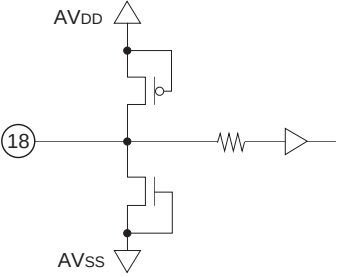
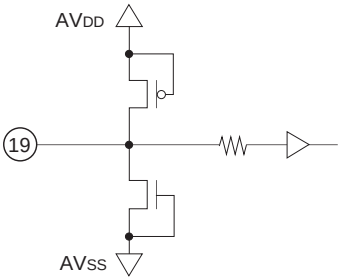
Block Diagram

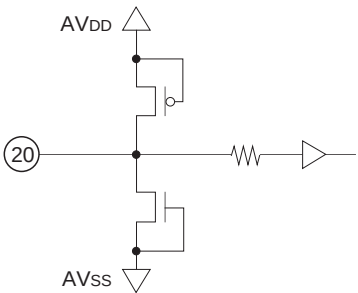
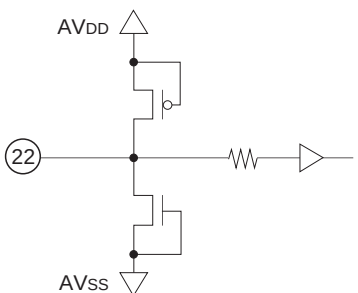
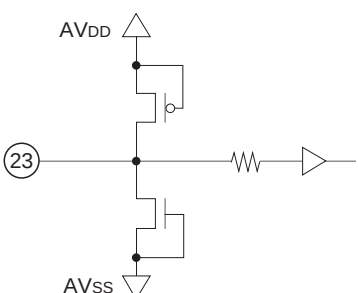
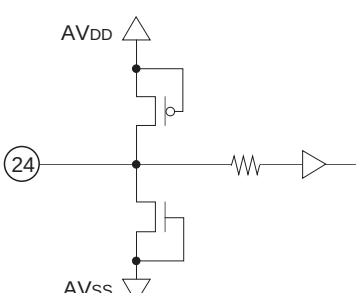


Pin Configuration

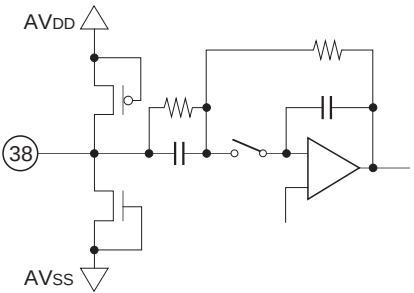
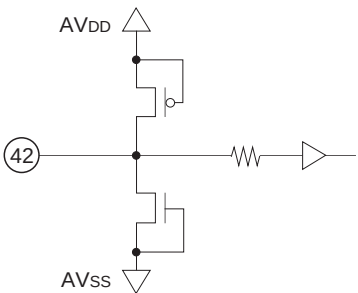


Pin Description

Pin No.	Symbol	Equivalent circuit	Description
1 to 5 8 to 12	D0 to D9		D0 (LSB) to D9 (MSB) output.
6, 48	DV _{SS}		Digital V _{SS} .
7, 47	DV _{DD}		Digital V _{DD} .
13	TO		Test pin. High impedance when TS = High.
14	TIN		Test signal input. Normally fixed to AV _{DD} or AV _{SS} .
15	RESET		Calibration circuit reset and startup calibration restart.
16, 25, 34, 41, 46	AV _{SS}		Analog V _{SS} .
17, 21, 26, 35, 40, 43, 45	AV _{DD}		Analog V _{DD} .
18	TESTMODE		Test mode. High: Output state Low: Output fixed
19	LINV		Output inversion. High: D0 to D8 are inverted and output. Low: D0 to D8 are normal output.

Pin No.	Symbol	Equivalent circuit	Description
20	MINV		Output inversion. High: D9 is inverted and output. Low: D9 is normal output.
22	CLK		Clock.
23	OE		D0 to D9 output enable. Low: Output state High: High impedance state
24	CE		Chip enable. Low: Active state High: Standby state

Pin No.	Symbol	Equivalent circuit	Description
27	VRTS		Self-bias. (Reference top)
28	VRT		Reference top.
29	VRTC		Reference top output.
30	VRMC		Reference middle output.
31	VRBC		Reference bottom output.
32	VRB		Reference bottom.
33	VRBS		Self-bias. (Reference bottom)
36	BE		Bias enable.

Pin No.	Symbol	Equivalent circuit	Description
37	TSTR		Test signal input. Normally fixed to AV _{DD} or AV _{SS} .
44	AT		Test signal input. High impedance when TS = High.
38	VIN		Analog input.
42	CAL		Calibration pulse input.
39	TS		Test signal input. Normally fixed to AV _{DD} .

Electrical Characteristics

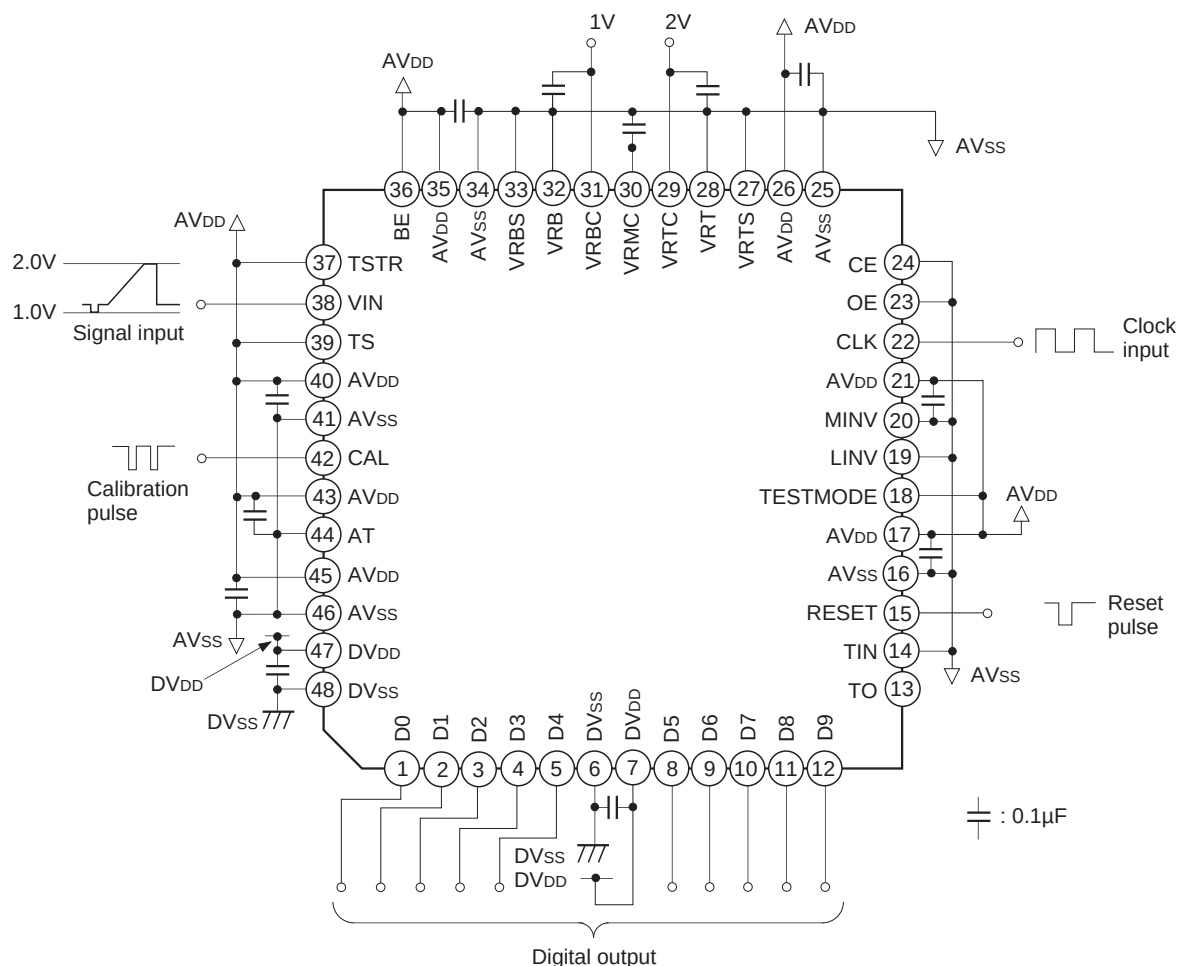
(F_C = 20MSPS, AV_{DD} = 3V, DV_{DD} = 3V, VRB = 1V, VRT = 2V, Ta = 25°C)

Item		Symbol	Conditions	Min.	Typ.	Max.	Unit
Maximum conversion rate		F _C max	F _{IN} = 1.0kHz sine wave input	20			MSPS
Minimum conversion rate		F _C min				0.5	
Supply current	Analog	I _{ADD}	F _{IN} = 1.0kHz sine wave input BE = High	11	14	17	mA
	Digital	I _{DD}			1.0	4	
Standby current	Analog	I _{AST}	CE = AV _{DD}			3.0	mA
	Digital	I _{DST}				1.0	
Reference pin current 1		I _{RT1}	VRTS, VRBS: Open Between VRT and VRB	87	97	111	μA
		I _{RB1}		-111	97	-87	
Reference pin current 2		I _{RT2}	BE = AV _{DD} Between VRTC and VRBC	1.81	2.04	2.33	mA
		I _{RB2}		-2.33	-2.04	1.81	
Analog input band		BW	-1dB		85		MHz
Analog input capacitance		C _{IN}			10		pF
Reference resistance value 1		R _{REF1}	Between VRTS and VRT, VRT and VRB, VRB and VRBS	9k	10.3k	11.5k	Ω
Reference resistance value 2		R _{REF2}	Between VRTC and VRBC	430	490	550	Ω
Offset voltage1		E _{OT1}	BE = AV _{DD} E _{OT1} = Theoretical value – Measured value	-30	+5	+40	mV
		E _{OB1}	E _{OB1} = Measured value – Theoretical value	-30	+5	+40	
Offset voltage2		E _{OT2}	BE = AV _{SS} E _{OT2} = Theoretical value – Measured value	-30	+5	+40	mV
		E _{OB2}	E _{OB2} = Measured value – Theoretical value	-20	+10	+40	
Digital input voltage		V _{IH}	AV _{DD} = 2.7 to 3.3V	0.7AV _{DD}			V
		V _{IL}				0.2AV _{DD}	
Analog input current		A _{IH}	V _{IN} = 2V	40	48	55	μA
		A _{IL}	V _{IN} = 1V	-55	-48	-40	
Digital input current		I _{IH}	AV _{DD} = 3.3V	V _{IH} = AV _{DD}		5	μA
		I _{IL}		V _{IL} = AV _{SS}		5	
Digital output current		I _{OH}	OE = AV _{SS} DV _{DD} = 2.7V	V _{OH} = DV _{DD} – 0.4V			mA
		I _{OL}		V _{OL} = 0.4V			
Digital output current		I _{OZH}	OE = AV _{DD} DV _{DD} = 3.3V	V _{OH} = DV _{DD}		1	μA
		I _{OZL}		V _{OL} = 0V		1	
Tri-state output disable time		t _{PEZ}	Clock not synchronized for active → high impedance	6	8	10	ns
Tri-state output enable time		t _{PZE}	Clock not synchronized for high impedance → active	3	5	7	ns
Integral nonlinearity error		E _L			±1.0	±3.0	LSB
Differential nonlinearity error		E _D			±0.5	±1.0	LSB

Item	Symbol	Conditions	Min.	Typ.	Max.	Unit
Differential gain error	DG	NTSC 40 IRE mod ramp, $F_c = 14.3\text{MSPS}$		1.0		%
Differential phase error	DP			0.3		deg
Output data delay	t_{DL}	$C_L = 3\text{pF}$, $T_a = -40$ to $+85^\circ\text{C}$	6	9	18	ns
Sampling delay	t_{SD}		6	7	8	ns
SNR	SNR	$F_{IN} = 100\text{kHz}$		50		dB
		$F_{IN} = 500\text{kHz}$		50		
		$F_{IN} = 1\text{MHz}$		50		
		$F_{IN} = 3\text{MHz}$		50		
		$F_{IN} = 7\text{MHz}$		45		
		$F_{IN} = 10\text{MHz}$		44		
SFDR	SFDR	$F_{IN} = 100\text{kHz}$		52		dB
		$F_{IN} = 500\text{kHz}$		52		
		$F_{IN} = 1\text{MHz}$		52		
		$F_{IN} = 3\text{MHz}$		52		
		$F_{IN} = 7\text{MHz}$		49		
		$F_{IN} = 10\text{MHz}$		50		

Application Circuit 1

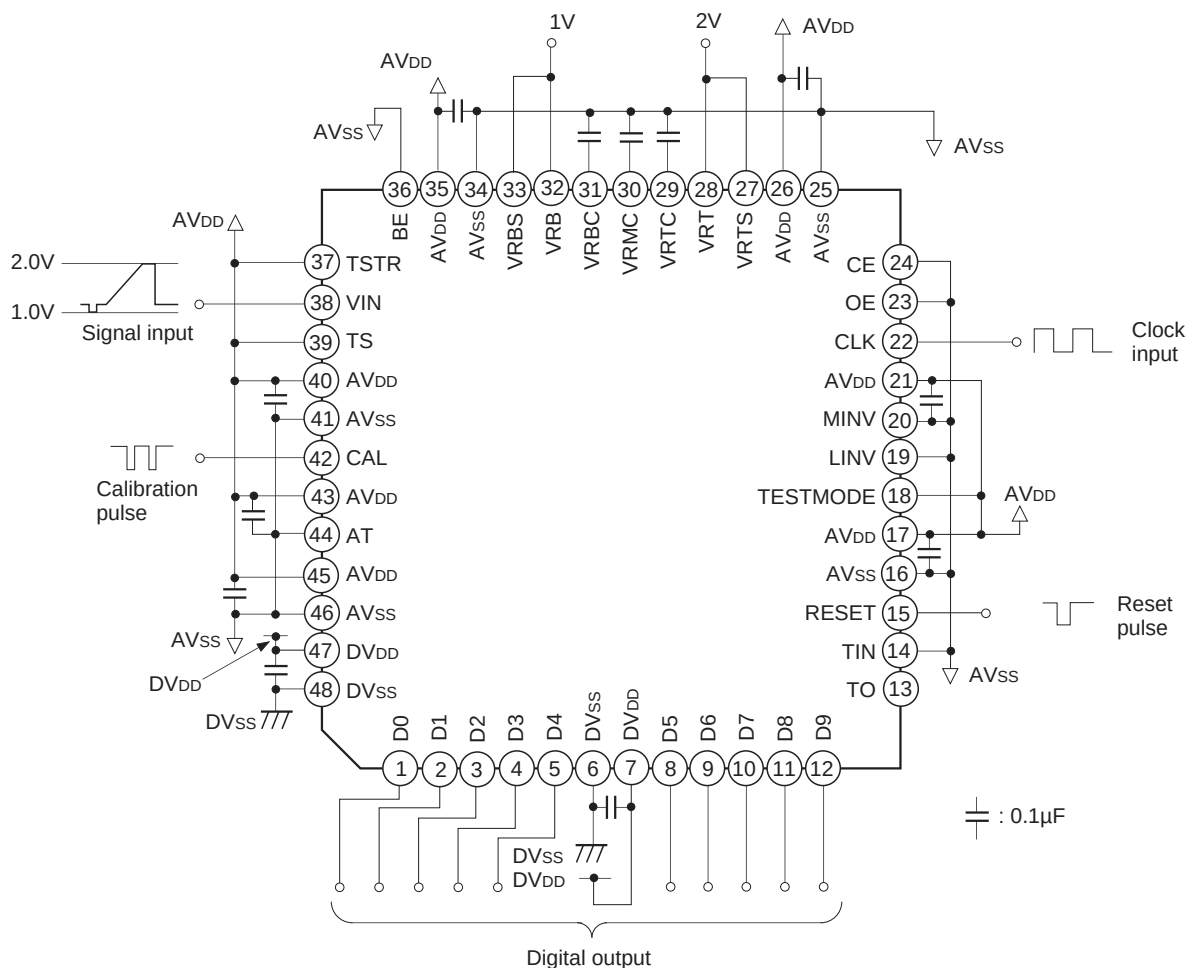
When not using self-bias and the internal bias circuits, and supplying the reference voltage from an external source.



Application circuits shown are typical examples illustrating the operation of the devices. Sony cannot assume responsibility for any problems arising out of the use of these circuits or for any infringement of third party patent and other right due to same.

Application Circuit 2

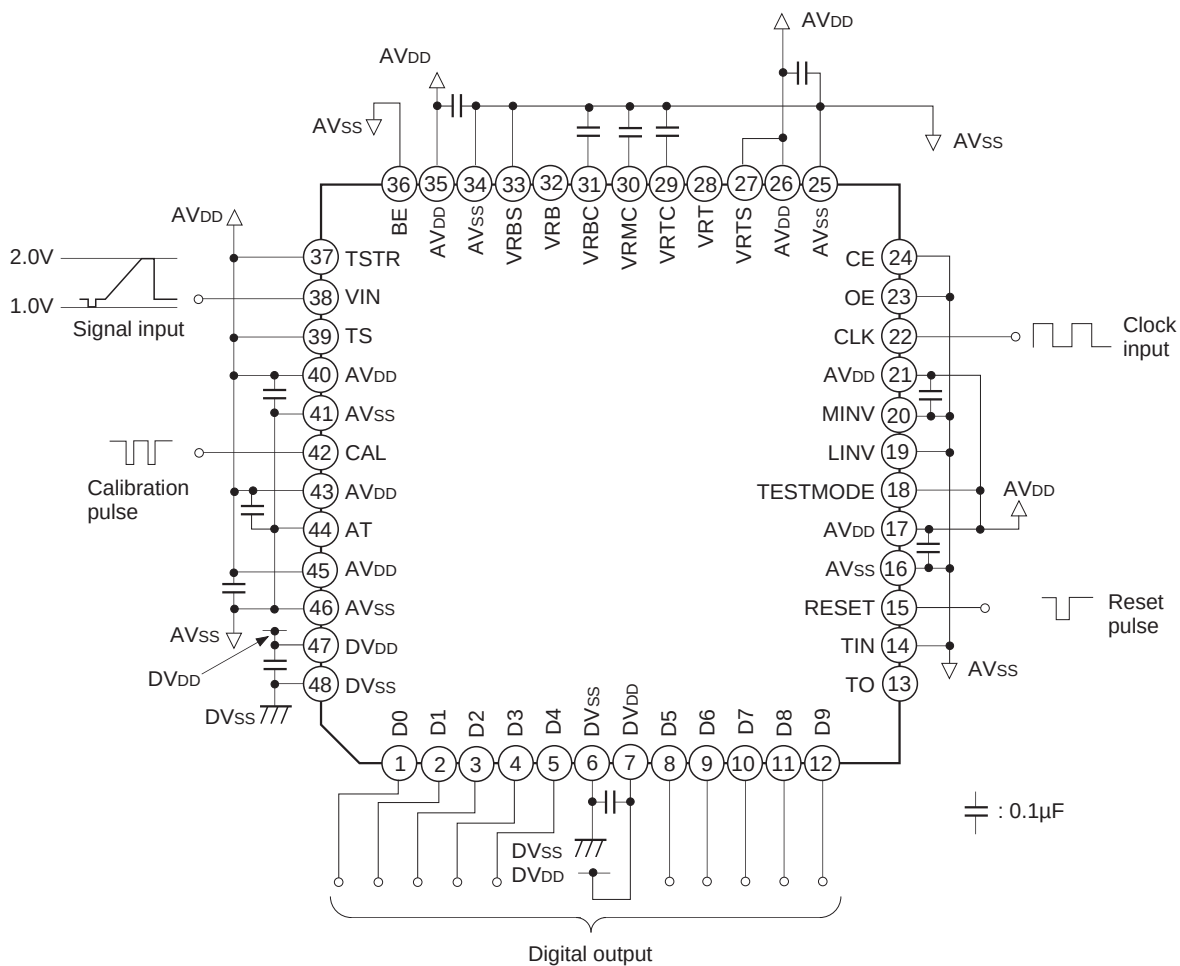
When not using self-bias circuit, using only the internal bias circuit, and supplying the reference voltage from an external source.



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Application Circuit 3

When using the self-bias and internal bias circuits, and supplying the reference voltage.



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1. Calibration function

1) Activating startup calibration

To achieve superior linearity, the CXD3300R has a built-in calibration circuit. When using this IC, therefore, startup calibration must be activated when the power supply and reference voltage have risen and stabilized. Care should be taken as only the upper five bits may be output in the worst case if startup calibration is not activated.

Startup calibration can be activated either at the rise of the RESET pin (Pin 15) or at the fall of the CE pin (Pin 24). The startup calibration activation method for each case is shown in Fig. 1.

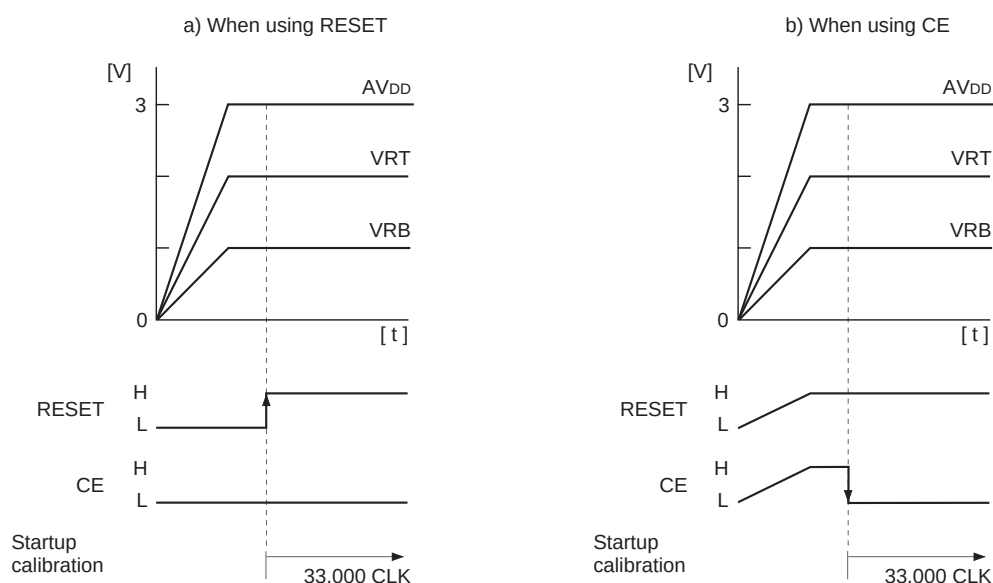


Fig. 1. Startup Calibration Activation Methods

As shown in the figure above, startup calibration must be activated after the supply voltage has risen and stabilized (full scale of 90% or more). After activation, startup calibration is performed for an interval of about 33,000 clocks. Therefore, care should be taken as the output data during this interval (about 2.3ms at 14.3MHz) cannot be used.

2) Calibration pulse supply

The IC's operating status with changes due to fluctuations in the supply voltage and ambient temperature during use can be constantly monitored and then compensated appropriately by inputting a pulse at regular intervals to the CAL pin (Pin 41). Fig. 2 shows the timing chart.

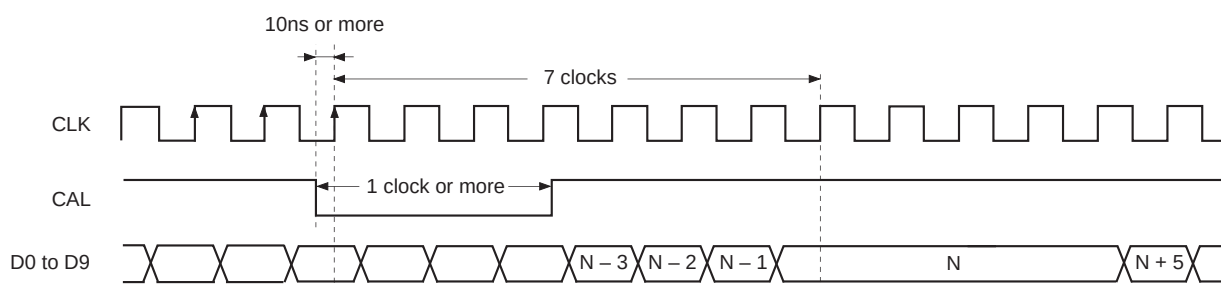
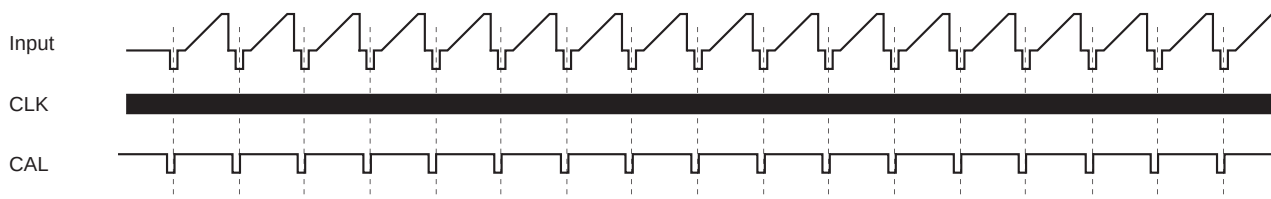


Fig. 2. Calibration Timing Chart

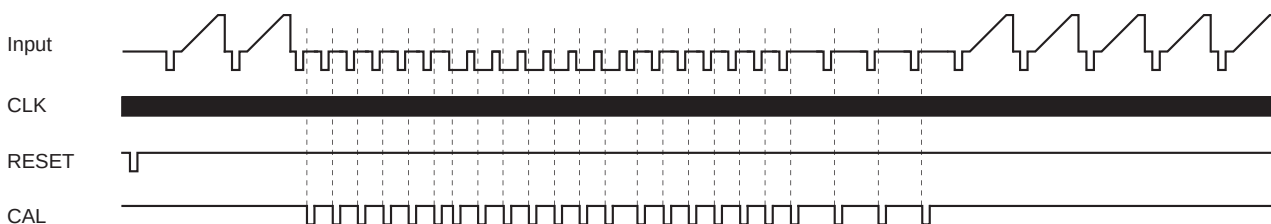
Calibration starts when the fall of the pulse input to the CAL pin (Pin 41) is detected at the clock rise. At this time, the comparator is used in an exclusive manner for a four clock interval. So, the output data holds the immediately previous data for a four clock interval after seven clocks from the rise of the clock where the fall of the calibration pulse was detected, and then the data during this interval is missing.

Therefore, the effects of this function can be avoided by inputting a sync or other signal as the calibration pulse so that calibration is performed outside of the interval of the actually used video signal. An input example is shown below.

[1] Input every H sync



[2] Input every V sync



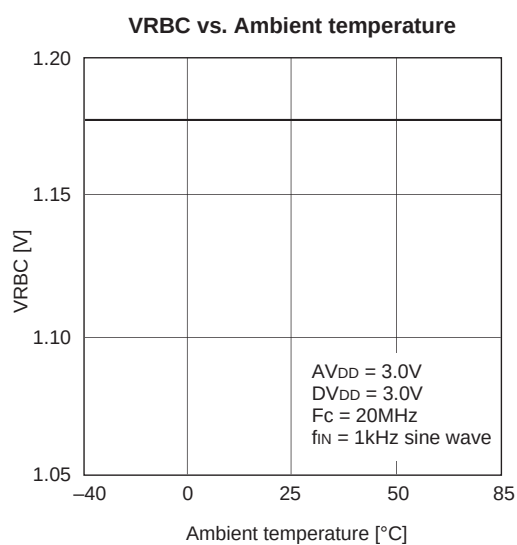
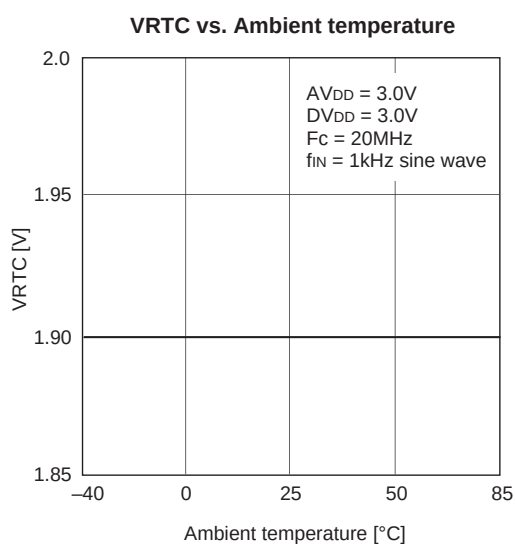
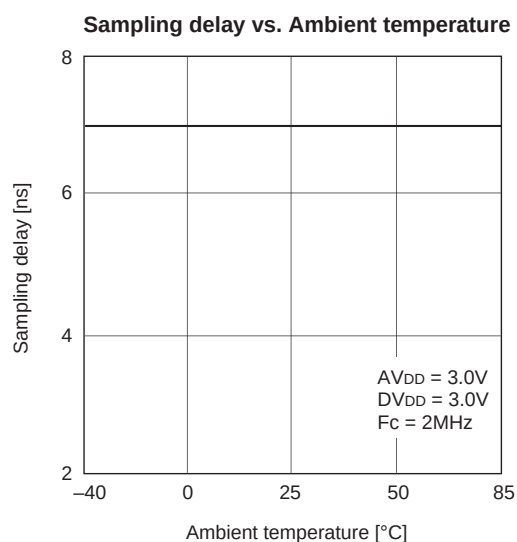
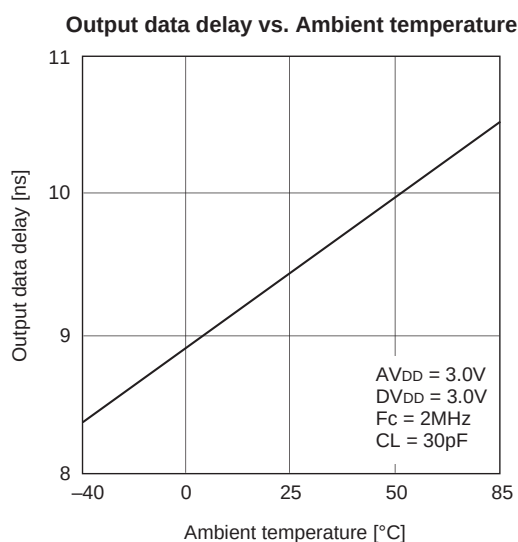
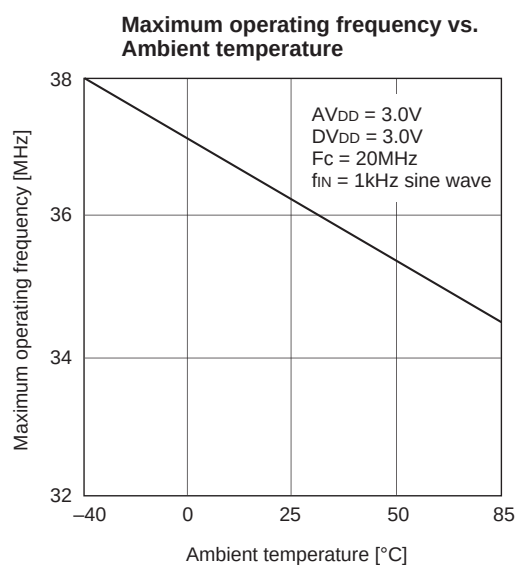
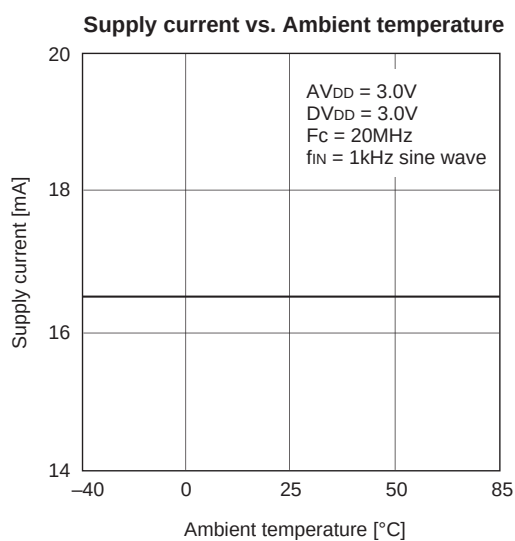
2. Latch-up

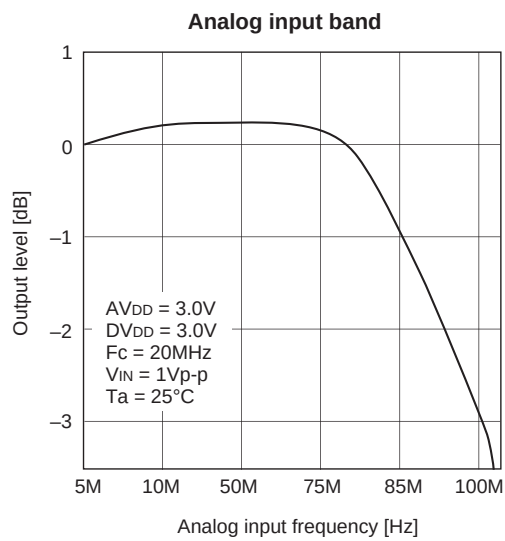
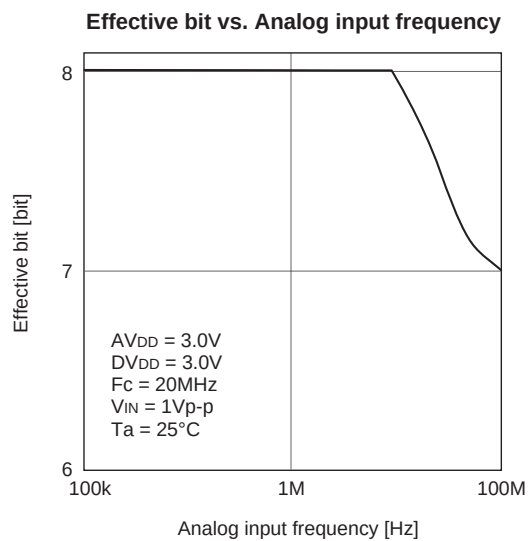
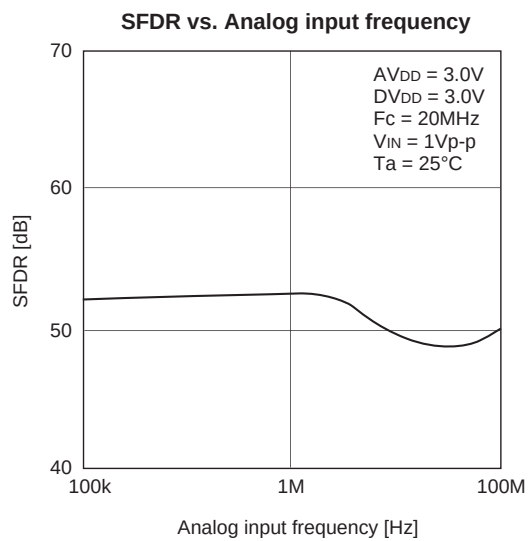
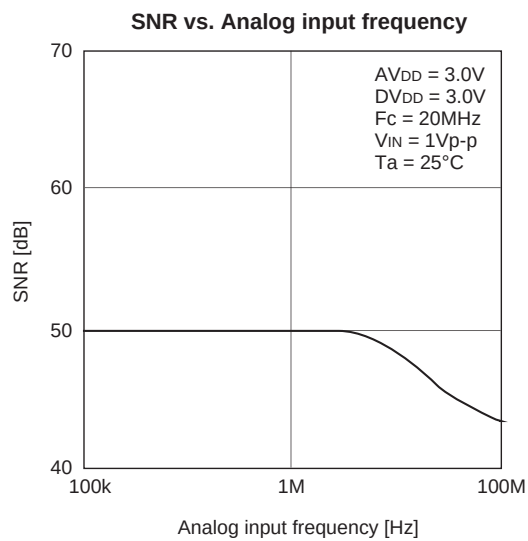
Ensure that the AV_{DD} and DV_{DD} pins share the same power supply on a board to prevent latch-up which may be caused by power-ON time lag.

3. Board

To obtain full-expected performance from this IC, be sure that the mounting board has a large ground pattern for lower impedance. It is recommended that the IC be mounted on a board without using a socket to evaluate its characteristics adequately.

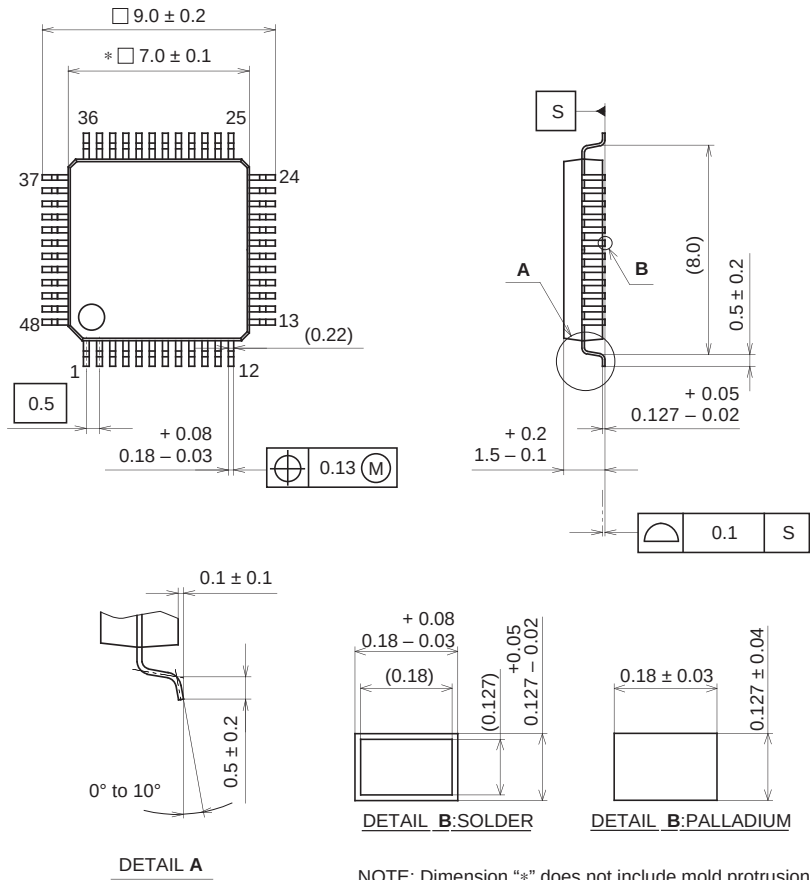
Example of Representative Characteristics





Package Outline Unit: mm

48PIN LQFP (PLASTIC)



PACKAGE STRUCTURE

SONY CODE	LQFP-48P-L01
EIAJ CODE	LQFP048-P-0707
JEDEC CODE	

PACKAGE MATERIAL	EPOXY RESIN
LEAD TREATMENT	SOLDER/PALLADIUM PLATING
LEAD MATERIAL	42/COPPER ALLOY
PACKAGE MASS	0.2g